

Search Notes

Application/Control No.

10/666,317

Examiner

Eric B. Chen

Applicant(s)/Patent under
Reexamination

MUI ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner
430	5	5/19/2005	EC
438	5,9,14,16	5/19/2005	EC
438	714,719	5/19/2005	EC
438	720,721	5/19/2005	EC
438	723,724	5/19/2005	EC
438	740,743	5/19/2005	EC
438	744	5/19/2005	EC
216	60,67,70	5/19/2005	EC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Performed inventor search for double patenting	5/12/2005	EC
EAST search	5/19/2005	EC
Confirmed search with Kin Chen	5/19/2005	EC